



JAPANESE
INDUSTRIAL
STANDARD

Translated and Published by
Japanese Standards Association

JIS C 1302 : 2025

(JSA)

Insulation resistance testers

Date of Establishment: 1968-04-01

Date of Revision: 2025-11-20

Date of Public Notice in Official Gazette: 2025-11-20

Developed by: Japanese Standards Association

Investigated by: JIS Development Committee on Electricity Technology

JIS C 1302 : 2025, First English edition published in 2026-01

Translated and published by: Japanese Standards Association
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In the event of any doubts arising as to the contents,
the original JIS is to be the final authority.

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Printed in Japan

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Contents

	Page
Introduction	1
1 Scope	1
2 Normative references	2
3 Terms and definitions	2
3.1 Performance	2
3.2 Safety and structure	5
4 Types of insulation resistance testers	6
5 Rated output voltage and effective maximum indicated value	6
6 Requirements	8
6.1 Rated operating conditions	8
6.2 Permissible range of limit deviation tolerance and deviation	8
6.3 Open-circuit voltage	9
6.4 Rated current	9
6.5 Short-circuit current	9
6.6 Output voltage	9
6.7 Influence when superimposing DC voltage	9
6.8 Influence of environment	9
6.9 Instantaneous maximum voltage	10
6.10 Battery check facility	10
6.11 Possible number of measurements	11
6.12 Safety	11
6.13 Measuring terminals	11
6.14 Resistance to vibration	12
6.15 Overvoltage protection	12
6.16 Type indication	13
6.17 Additional functions	13
6.18 Hazard indicator	13
6.19 Discharging residual voltages	13
7 Marking and operating instructions	13
7.1 Marking on product	13
7.2 Operating instructions	14
8 Tests	15
8.1 Test conditions and reference conditions	15
8.2 Permissible range of limit deviation tolerance, intrinsic uncertainty and deviation	15
8.3 Open-circuit voltage	15

8.4	Rated current	16
8.5	Short-circuit current	16
8.6	Output voltage	16
8.7	Influence when superimposing DC voltage	17
8.8	Influence of environment	17
8.9	Instantaneous maximum voltage	18
8.10	Battery check facility	18
8.11	Possible number of measurements	18
8.12	Safety	18
8.13	Measuring terminals	18
8.14	Resistance to vibration	19
8.15	Overvoltage protection	19
8.16	Type indication	19
8.17	Additional functions	19
8.18	Hazard indicator	19
8.19	Discharging residual voltages	20
8.20	Marking and operating instructions	20
8.21	Records of test results	20
9	Inspections	20
9.1	Type inspection	20
9.2	Acceptance inspection	20
Annex JA (informative)	Comparison table between JIS and corresponding International Standards	22

Foreword

This Japanese Industrial Standard has been revised by the Minister of Economy, Trade and Industry based on the provision of Article 14, paragraph (1) of the Industrial Standardization Act applied *mutatis mutandis* pursuant to the provision of Article 16 of the said Act in response to a proposal for revision of Japanese Industrial Standard with a draft being attached, submitted by Japanese Standards Association (JSA), an accredited standards development organization. This edition replaces the previous edition (**JIS C 1302 : 2018**), which has been technically revised.

However, **JIS C 1302 : 2018** may be applied in the **JIS** mark certification based on the relevant provisions of Article 30, paragraph (1), etc. of the Industrial Standardization Act until 19 November 2026.

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Insulation resistance testers

Introduction

This Japanese Industrial Standard has been prepared based on **IEC 61557-1** : 2019, Edition 3, and its Amendment 1 : 2024, as well as **IEC 61557-2** : 2019, Edition 3, with some modifications of the technical contents. The amendment to the said International Standard has been incorporated into this Standard.

The vertical lines on both sides and dotted underlines indicate changes from the corresponding International Standards. A list of modifications with the explanations is given in Annex JA.

1 Scope

This Standard specifies requirements for portable insulation resistance testers of built-in battery type with rated output voltages of up to 1 000 V, which are used for the following a) to e).

a) Insulation measurement of low-voltage distribution circuits The insulation measurement of circuits and equipment in distribution systems up to 1 000 V AC and 1 500 V DC, which are disconnected from the power source.

b) Insulation measurement of equipment, appliances, components, etc.

NOTE 1 Photovoltaic arrays that are not in a power generating state are categorized as appliances or components.

c) Insulation measurement of high-voltage facilities

d) Insulation measurement of photovoltaic arrays in a power generating state by short-circuiting P-N terminals

e) Insulation measurement of photovoltaic arrays in a power generating state without short-circuiting P-N terminals

NOTE 2 The International Standards corresponding to this Standard and the symbol of degree of correspondence are as follows.

IEC 61557-1 : 2019 *Electrical safety in low voltage distribution systems up to 1 000 V a.c. and 1 500 V d.c. — Equipment for testing, measuring or monitoring of protective measures — Part 1: General requirements* + Amendment 1 : 2024

IEC 61557-2 : 2019 *Electrical safety in low voltage distribution systems up to 1 000 V a.c. and 1 500 V d.c. — Equipment for testing, measuring or monitoring of protective measures — Part 2: Insulation resistance* (overall evaluation: MOD)

In addition, symbols which denote the degree of correspondence in the contents between the relevant International Standard and **JIS** are IDT (identical), MOD (modified), and NEQ (not equivalent) according to **ISO/IEC Guide 21-1**.